

Search Notes

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Examiner

Alex Liew

Applicant(s)/Patent under
Reexamination

ENDO ET AL.

Art Unit

2624

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
382/106,154 limited to text search	4/23/2007	AL
348/36-39 limited to text search	4/23/2007	AL
382/274 limited to text search	4/25/2007	AL